

Notice of References Cited	Application/Control No. 10/536,652	Applicant(s)/Patent Under Reexamination YEO ET AL.	
	Examiner Reema Patel	Art Unit 2812	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0087057 A1	05-2004	Wang et al.	438/106
*	B	US-6,812,065 B1	11-2004	Kitamura, Tadashi	438/119
*	C	US-6,153,525	11-2000	Hendricks et al.	438/692
*	D	US-6,555,414	04-2003	Vanfleteren et al.	438/108
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	P					
	Q					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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